

# Search Notes



Application/Control No.

10/724,037

Examiner

Sherrie Hsia

Applicant(s)/Patent under  
Reexamination

SHIN ET AL.

Art Unit

2622

## SEARCHED

Class	Subclass	Date	Examiner
348	745-747, 806, 807	5/06	SH
315	368.11		
	368.12		
	368.18		
H04N	3/23		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	5/06	SH